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A Inter Chip-USB Voltage Level Translator

Check for Samples: TXS0202

FEATURES

- No Direction Control Signal Required
- V_{CCA}, V_{CCB} Supply Voltage: 1.65 V to 3.6 V
- Meets All Requirements of the IC-USB Standard
- Small Packages: WCSP
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- I_{off} Supports Partial-Power-Down Mode Operation
- ESD Performance
 - A port (Host-Side)
 - 2000-V Human-Body Model
 - 100-V Machine Model
 - 500-V Charged-Device Model
 - B port (Peripheral-Side)
 - >4kV HBM

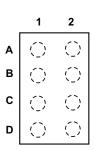


Table 1. YZP TERMINAL ASSIGNMENTS (Top Through View)

	1	2
Α	D+(B)	D-(B)
В	GND	V _{CCB}
С	V _{CCA}	OE
D	D+(A)	D-(A)

DESCRIPTION

The TXS0202 is a 2-bit voltage level translator optimized for use in Interchip USB (IC-USB) applications. V_{CCA} and V_{CCB} can each operate over the full range of 1.65 V to 3.6 V. The device has been designed to maintain cross-over skew to be less than 1 ns. The device has integrated pull-ups and pull-down resistors to aid in the protocol communication between a host and a peripheral. The translator is a buffered auto-direction sensing type translator. When the output-enable (OE) input is low, all outputs are placed in the high-impedance state.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pull-down resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

ORDERING INFORMATION(1)

T _A	PACK	AGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 85°C	WSCP - YZP	Tape and reel	TXS0202YZPR	7PS _ ⁽³⁾

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



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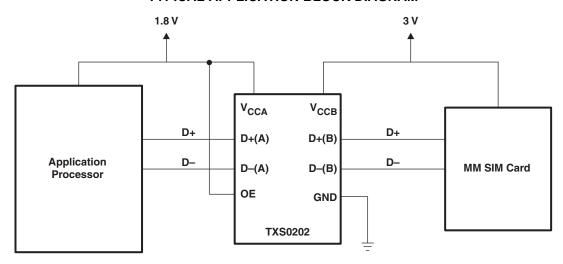
⁽³⁾ YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the wafer fab/assembly site.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

TYPICAL APPLICATION BLOCK DIAGRAM



PIN FUNCTIONS

Р	IN	
WSCP (YFP) BALL NO.	NAME	DESCRIPTION
A1	D+(B)	USB data signal connected to peripheral
A2	D-(B)	USB data signal connected to peripheral
B1	GND	Ground
B2	V _{CCB}	B-side supply voltage (1.65 V to 3.6 V)
C1	V _{CCA}	A-side supply voltage (1.65 V to 3.6 V)
C2	OE	Output enable input control
D1	D+(A)	USB data signal connected to host
D2	D-(A)	USB data signal connected to host

FUNCTIONAL TABLE

CONTROL INPUT	OUTPUT CIRCUIT	OPERATION				
OE	B PORT	OPERATION				
L	Hi-Z	Isolation				
Н	Enabled	Bi-directional communications between host and peripheral				

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ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CCA}	Supply voltage rang	-0.5	4.6	V	
V_{I}	Input voltage range	A port, B port, control inputs	-0.5	$V_{CCx} + 0.5$	V
Vo	Voltage range applied to any output in the high-impedance or power-off state	A port, B port	-0.5	V _{CCx} + 0.5	V
I_{lK}	Input clamp current	V _I < 0		– 50	mA
I _{OK}	Output clamp current	V _O < 0		– 50	mA
I _{CC}	Continuous current through V_{CCA} , V_{CCB} , o		±100	mA	
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

THERMAL INFORMATION

	TXS0202	
THERMAL METRIC ⁽¹⁾	YZP	UNITS
	8 PINS	
θ _{JA} Junction-to-ambient thermal resistance	102	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

RECOMMENDED OPERATING CONDITIONS

			MIN	MAX	UNIT
V _{CCA} , V _{CCB}	Supply voltage		1.65	3.6	V
V _{IH}		A port I/Os	V _{CCA} - 0.2	V_{CCA}	
	High-level input voltage	B port I/Os	V _{CCB} - 0.2	V_{CCB}	V
		OE	V _{CCA} × 0.65	3.6	
		A port I/Os	0	0.15	
V_{IL}	Low-level input voltage	B port I/Os	0	0.15	V
		OE	0	$V_{CCA} \times 0.35$	
Δt/Δν	Input transition rise or fall ra	ate		10	ns/V
T _A	Operating free-air temperat	ure	-40	85	°C

Product Folder Link(s): TXS0202



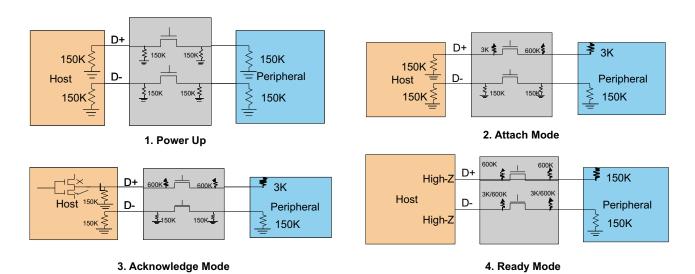


Figure 1. Block Diagram Showing Different Modes in the TXS0202

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ELECTRICAL CHARACTERISTICS

PARAMETER	TEST CONDITIONS	V	V	$T_A = 25^{\circ}C$	$T_A = -40^{\circ}C$ to	85°C	UNIT	
PARAMETER	TEST CONDITIONS	V _{CCA}	V _{CCBx}	TYP	MIN	MAX	UNII	
		1.65 V	1.65 V		V _{CCO} × 0.67			
V _{OH(D-)} (D– A or B port)	$I_{OH} = -20 \mu A,$ $V_{Ix} \ge V_{CCx} - 0.2 V$	2.3 V	2.3 V		V _{CCO} × 0.67		V	
	V _X ≥ V _{CCX} − 0.2 V	3.3 V	3.3 V		V _{CCO} × 0.67			
	$I_{OL} = 220 \mu A, V_{Ix} \le 0.15 V$	1.65 V	1.65 V			0.45		
V _{OL(D-)} (D– A or B port)	$I_{OL} = 180 \ \mu A, \ V_{Ix} \le 0.15 \ V$	2.3 V	2.3 V			0.55	V	
	$I_{OL} = 220 \mu A, V_{Ix} \le 0.15 V$	3.3 V	3.3 V			0.7		
		1.65 V	1.65 V		V _{CCO} × 0.67			
$V_{OH(D+)}$ (D+ A or B port)	$I_{OH} = -20 \mu A,$ $V_{Ix} \ge V_{CCx} - 0.2 V$	2.3 V	2.3 V		V _{CCO} × 0.67		V	
	V _X ≥ V _{CCX} − 0.2 V	3.3 V	3.3 V		V _{CCO} × 0.67			
	$I_{OL} = 220 \mu A, V_{Ix} \le 0.15 V$	1.65 V	1.65 V			0.45		
V _{OL(D+)} (D– A or B port)	$I_{OL} = 300 \ \mu A, \ V_{Ix} \le 0.15 \ V$	2.3 V	2.3 V			0.55	V	
	$I_{OL} = 620 \mu A, V_{Ix} \le 0.15 V$	3.3 V	3.3 V			0.7		
	OE			±2		±2		
I _I	D-/D+ A or B port, OE = OPEN	1.65 V to 3.6 V	1.65 V to 3.6 V	±2		±2	μΑ	
	I _{BOFF} , D+, D– B port	1.65 V to 3.6 V	0 V			±2	•	
	I _{AOFF} , D+, D– A port	0 V	1.65 V to 3.6 V			±2		
		1.65 V to 3.6 V	1.65 V to 3.6 V	2.2		12		
I _{CCA}	$V_I = V_O = Open,$ OE = High	3.6 V	0 V	2.3		12	μΑ	
	OL = High	0 V	3.6 V	0.026		-1	·	
		1.65 V to 3.6 V	1.65 V to 3.6 V	2.7		24		
I _{CCB}	V _I = V _O = Open, OE = High	3.6 V	0 V	0.031		-12	μΑ	
	OL = High	0 V	3.6 V	2.7		24	-	
C _i	OE	3.6 V	3.6 V	2.5		3.5	pF	
0	A port	0.01/	0.01/	7		7.5		
C_{io}	B port	3.6 V	3.6 V	9.5		10	pF	

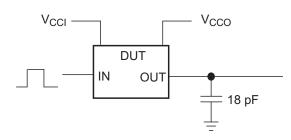


SWITCHING CHARACTERISTICS

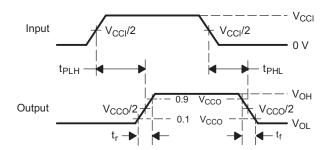
over recommended operating free-air temperature range, $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V}$ (unless otherwise noted)

PARAMETER	FROM	то	V_{CCB} = 1.8 V ± 0.15 V	V_{CCB} = 3.3 V \pm 0.3 V	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	TYP	TYP	UNIT	
	Α	В	5	5	9.0	
t _{pd}	В		5	5	ns	
t _{rA}	A port rise times		2	2	ns	
t _{fA}	A port fa	all times	2	2	ns	
t _{rB}	B port ris	se times	2	2	ns	
t _{fB}	B port fa	all times	2	2	ns	
t _{sk(o)}	Channel-to	o-channel	0.5	0.5	ns	
Max data rate			15	15	Mbps	

PARAMETER MEASUREMENT INFORMATION



DATA RATE, SKEW, PROPAGATION DELAY, OUTPUT RISE AND FALL TIME MEASUREMENT



VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES

- A. C_L includes probe and jig capacitance.
- B. The outputs are measured one at a time, with one transition per measurement.
- C. t_{PLH} and t_{PHL} are the same as t_{pd} .



PACKAGE OPTION ADDENDUM

20-May-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)		Device Marking	Samples
	(1)		Drawing		Qty	(2)		(3)			(4/5)	
TXS0202YZPR	ACTIVE	DSBGA	YZP	8	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	7P		Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TXS0202YZPR	DSBGA	YZP	8	3000	180.0	8.4	1.02	2.02	0.63	4.0	8.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TXS0202YZPR	DSBGA	YZP	8	3000	182.0	182.0	20.0



DIE SIZE BALL GRID ARRAY



NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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